Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/792,237	FUJITA ET AL.	
Examiner	Art Unit	
PHILIP R. SMITH	3739	

	SEAR	CHED	
Class	Subclass	Date	Examiner
search	updated	2/6/2008	PRS

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
search updated	2/6/2008	PRS	